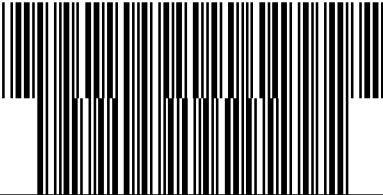


<b>Search Notes</b>  	<b>Application/Control No.</b>  1058554811612088	<b>Applicant(s)/Patent Under Reexamination</b>  NAGAO ET AL.MARYA ET AL.
	<b>Examiner</b>  Deborah YeeDeborah Yee	<b>Art Unit</b>  17931793

SEARCHED			
Class	Subclass	Date	Examiner
420148	59,65,74654,663.320,330-336	1/15/091/21/09	/DY//DY/

SEARCH NOTES		
Search Notes	Date	Examiner
west and inventorship searchwest and inventorship search	1/15/091/21/09	/DY//DY/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
148	663,654	1/21/09	/DY/

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